OptiMOS® Power-Transistor

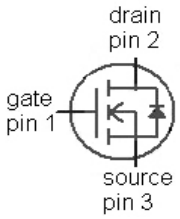
Features

- For fast switching converters and sync. rectification
- N-channel enhancement - normal level
- 175 °C operating temperature
- Avalanche rated
- Pb-free lead plating, RoHS compliant

Product Summary

V_{DS}	60	V
$R_{DS(on),max}$	80	mΩ
I_D	16	A

Type	IPD800N06N G
	
Package	P-TO252-3-11
Marking	800N06N



Maximum ratings, at T_j=25 °C, unless otherwise specified

Parameter	**Symbol**	**Conditions**	**Value**	**Unit**
Continuous drain current	I_D	T_C=25 °C	16	A
		T_C=100 °C	11	
Pulsed drain current	$I_{D,pulse}$	T_C=25 °C[1)]	64	
Avalanche energy, single pulse	E_{AS}	I_D=16 A, R_{GS}=25 Ω	43	mJ
Reverse diode dv/dt	dv/dt	I_D=16 A, V_{DS}=48 V, di/dt=200 A/µs, $T_{j,max}$=175 °C	6	kV/µs
Gate source voltage	V_{GS}		±20	V
Power dissipation	P_{tot}	T_C=25 °C	47	W
Operating and storage temperature	T_j, T_{stg}		-55 ... 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

[1)] See figure 3

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	R_{thJC}		-	-	3.2	K/W
SMD version, device on PCB	R_{thJA}	minimal footprint	-	-	75	
		6 cm^2 cooling area[2)]	-	-	50	
Electrical characteristics, at T_j=25 °C, unless otherwise specified						
Static characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	V_{GS}=0 V, I_D=1 mA	60	-	-	V
Gate threshold voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_D=16 µA	2.1	3	4	
Zero gate voltage drain current	I_{DSS}	V_{DS}=60 V, V_{GS}=0 V, T_j=25 °C	-	0.01	1	µA
		V_{DS}=60 V, V_{GS}=0 V, T_j=125 °C	-	1	100	
Gate-source leakage current	I_{GSS}	V_{GS}=20 V, V_{DS}=0 V	-	10	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	V_{GS}=10 V, I_D=16 A	-	54	80	mΩ
Gate resistance	R_G		-	1	-	Ω
Transconductance	g_{fs}	$\|V_{DS}\|>2\|I_D\|R_{DS(on)max}$, I_D=16 A	7	14	-	S

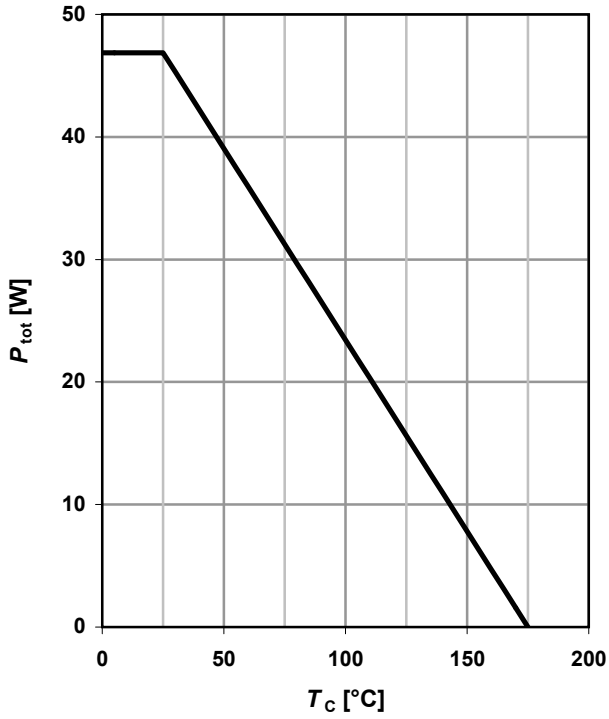
[2)] Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm^2 (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C_{iss}	V_{GS}=0 V, V_{DS}=30 V, f=1 MHz	-	280	370	pF
Output capacitance	C_{oss}		-	75	100	
Reverse transfer capacitance	C_{rss}		-	22	33	
Turn-on delay time	$t_{d(on)}$	V_{DD}=30 V, V_{GS}=10 V, I_D=16 A, R_G=39 Ω	-	7	11	ns
Rise time	t_r		-	38	57	
Turn-off delay time	$t_{d(off)}$		-	22	33	
Fall time	t_f		-	27	40	
Gate Charge Characteristics[3)]						
Gate to source charge	Q_{gs}	V_{DD}=30 V, I_D=16 A, V_{GS}=0 to 10 V	-	1.7	2.2	nC
Gate charge at threshold	$Q_{g(th)}$		-	0.8	1.1	
Gate to drain charge	Q_{gd}		-	3.3	4.9	
Switching charge	Q_{sw}		-	4.1	6.0	
Gate charge total	Q_g		-	7	10	
Gate plateau voltage	$V_{plateau}$		-	6.0	-	V
Output charge	Q_{oss}	V_{DD}=30 V, V_{GS}=10 V	-	4	5	
Reverse Diode						
Diode continous forward current	I_S	T_C=25 °C	-	-	16	A
Diode pulse current	$I_{S,pulse}$		-	-	64	
Diode forward voltage	V_{SD}	V_{GS}=0 V, I_F=16 A, T_j=25 °C	-	0.97	1.3	V
Reverse recovery time	t_{rr}	V_R=30 V, I_F=I_S, di_F/dt=100 A/µs	-	25	31	ns
Reverse recovery charge	Q_{rr}		-	35	44	nC

[3)] See figure 16 for gate charge parameter definition

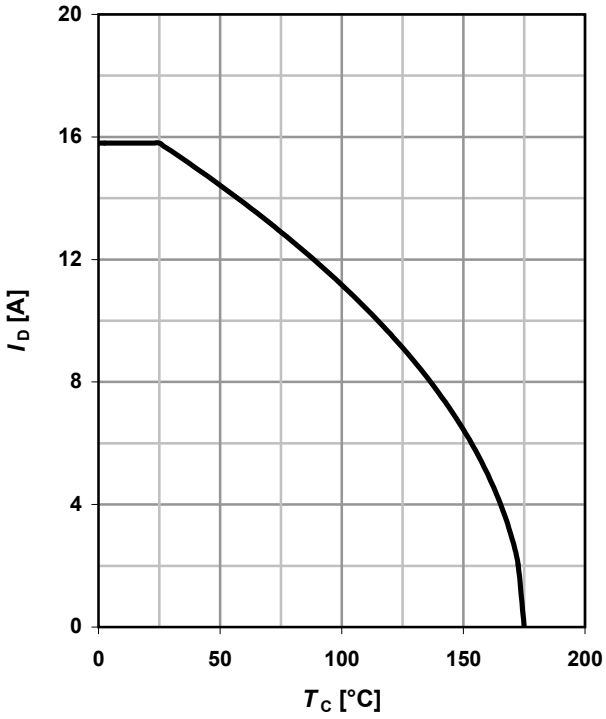
1 Power dissipation

$P_{tot}=f(T_C)$; $V_{GS}\geq 6$ V



2 Drain current

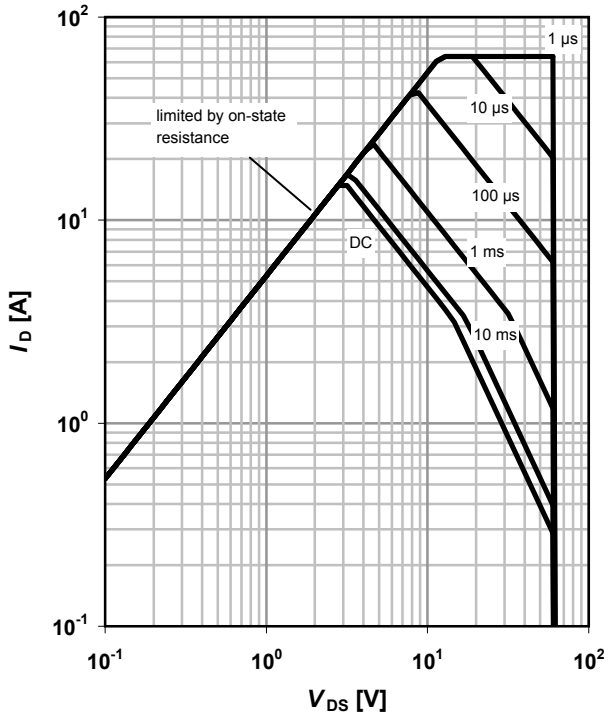
$I_D=f(T_C)$; $V_{GS}\geq 10$ V



3 Safe operating area

$I_D=f(V_{DS})$; $T_C=25$ °C; $D=0$

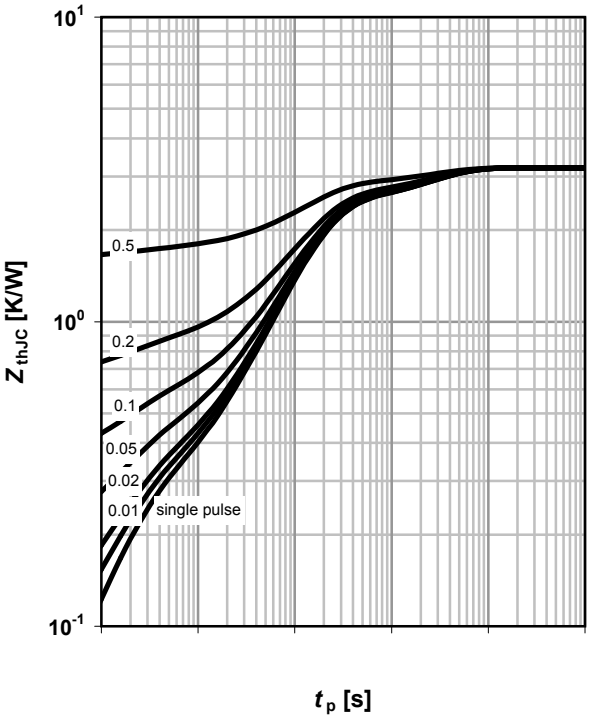
parameter: t_p



4 Max. transient thermal impedance

$Z_{thJC}=f(t_p)$

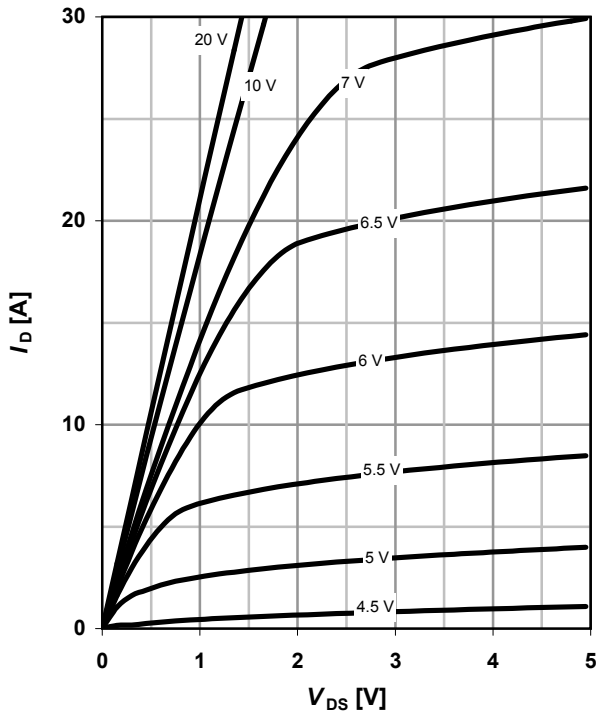
parameter: $D=t_p/T$



5 Typ. output characteristics

I_D=f(V_{DS}); T_j=25 °C

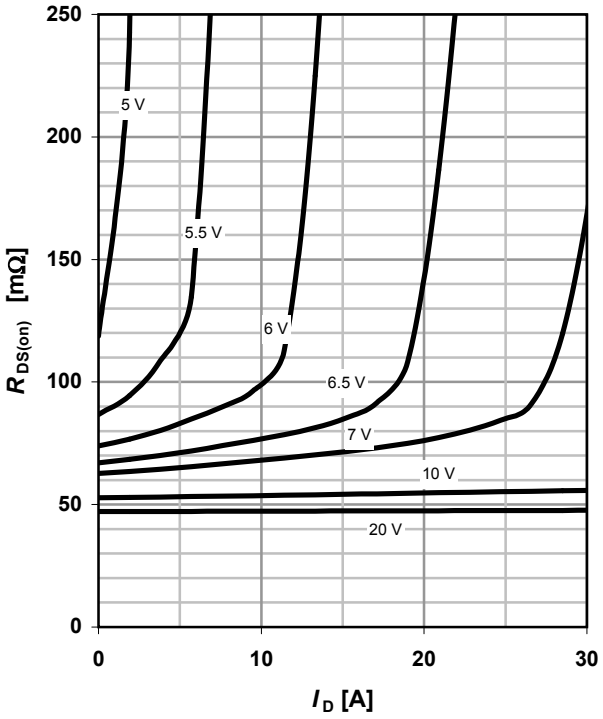
parameter: V_{GS}



6 Typ. drain-source on resistance

$R_{DS(on)}$=f(I_D); T_j=25 °C

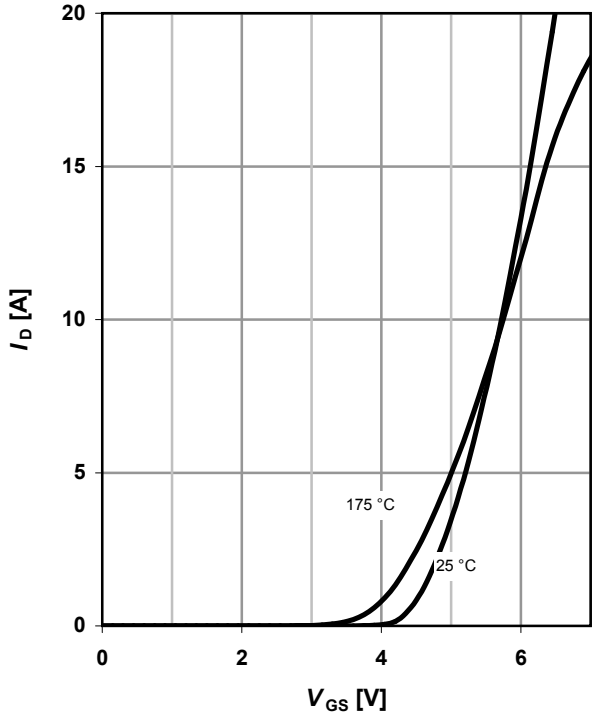
parameter: V_{GS}



7 Typ. transfer characteristics

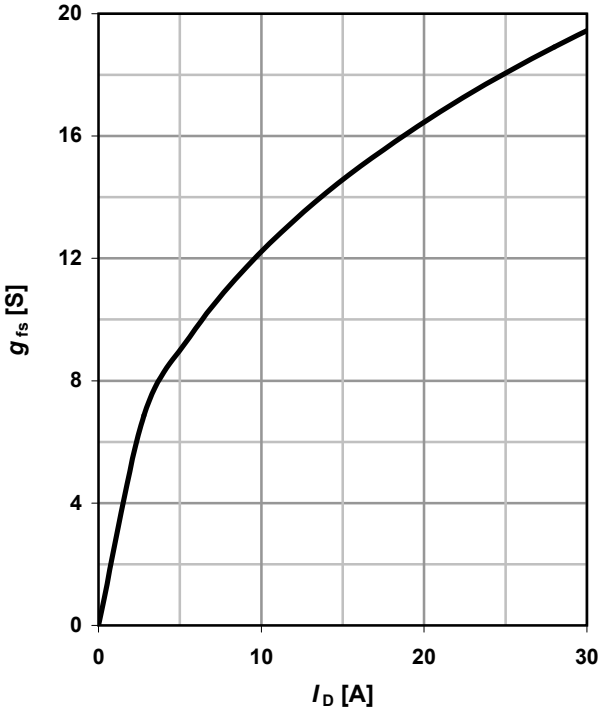
I_D=f(V_{GS}); $|V_{DS}|>2|I_D|R_{DS(on)max}$

parameter: T_j



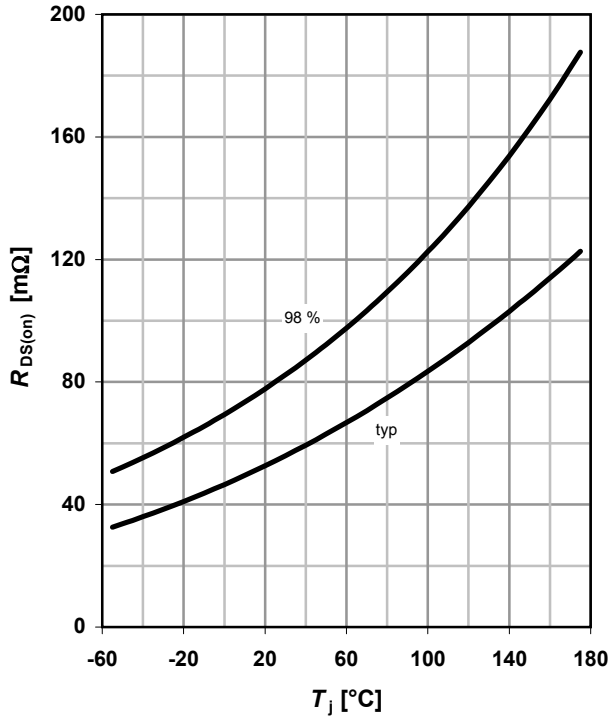
8 Typ. forward transconductance

g_{fs}=f(I_D); T_j=25 °C



9 Drain-source on-state resistance

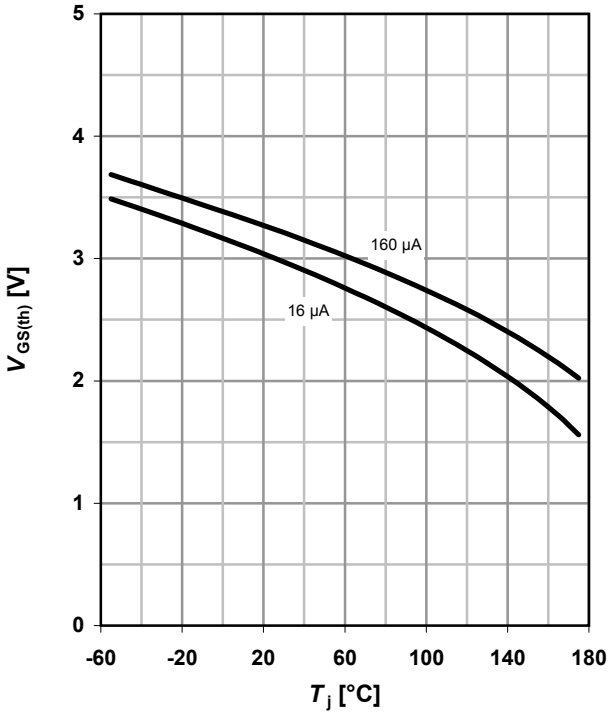
$R_{DS(on)}$=f(T_j); I_D=16 A; V_{GS}=10 V



10 Typ. gate threshold voltage

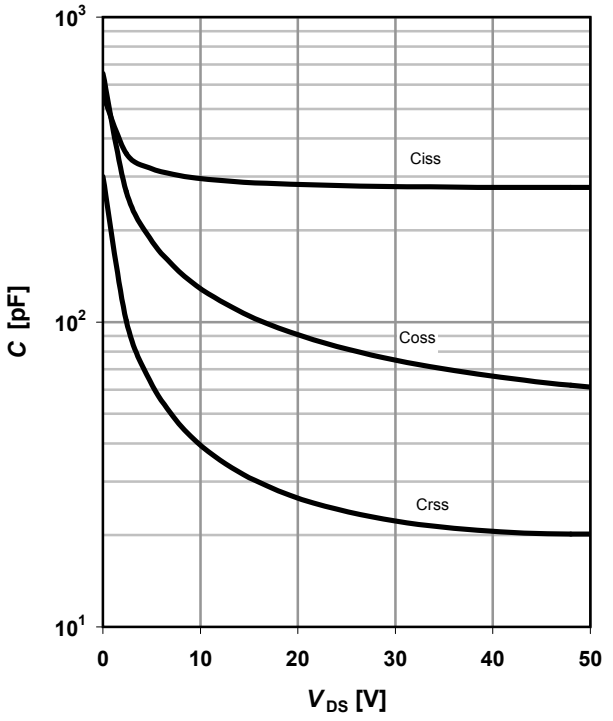
$V_{GS(th)}$=f(T_j); V_{GS}=V_{DS}

parameter: I_D



11 Typ. capacitances

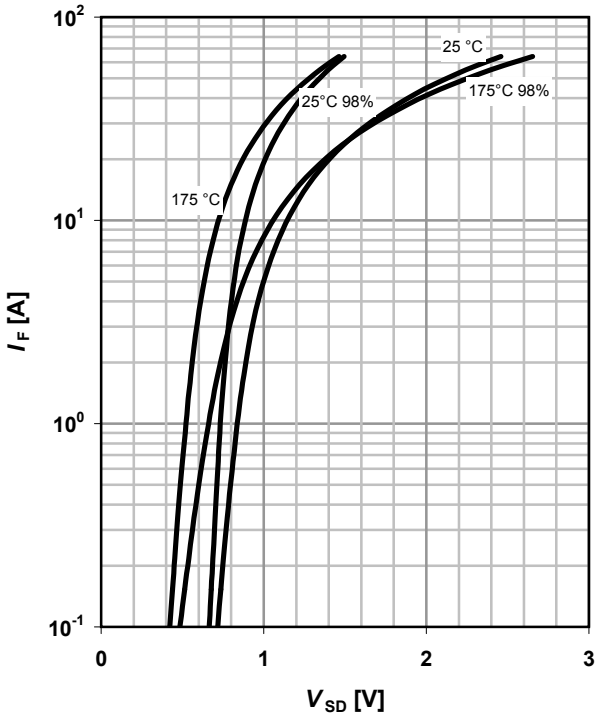
C=f(V_{DS}); V_{GS}=0 V; f=1 MHz



12 Forward characteristics of reverse diode

I_F=f(V_{SD})

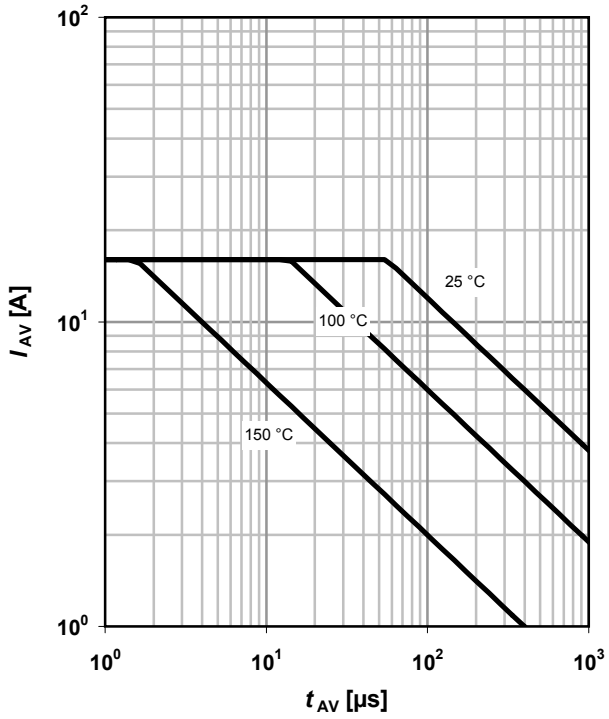
parameter: T_j



13 Avalanche characteristics

I_{AS}=f(t_{AV}); R_{GS}=25 Ω

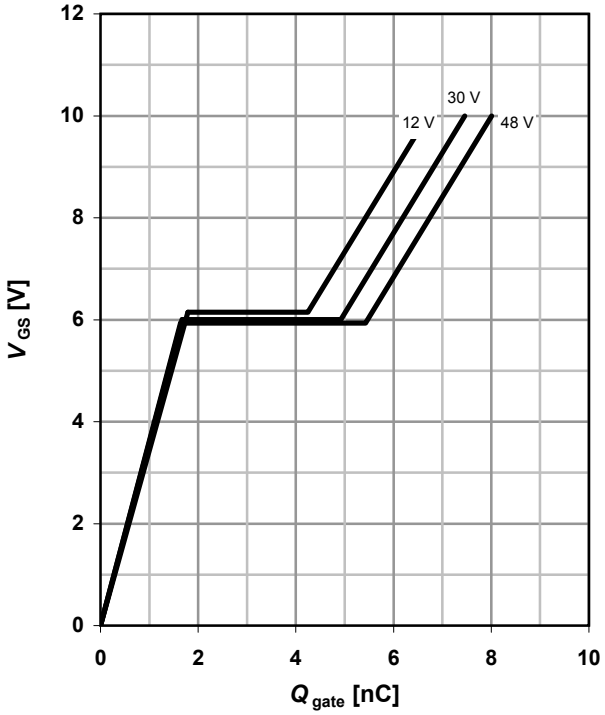
parameter: $T_{j(start)}$



14 Typ. gate charge

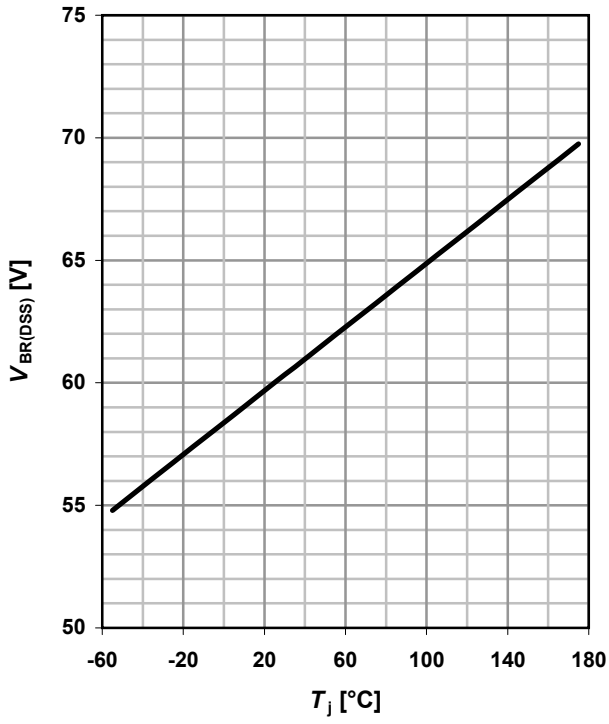
V_{GS}=f(Q_{gate}); I_D=16 A pulsed

parameter: V_{DD}

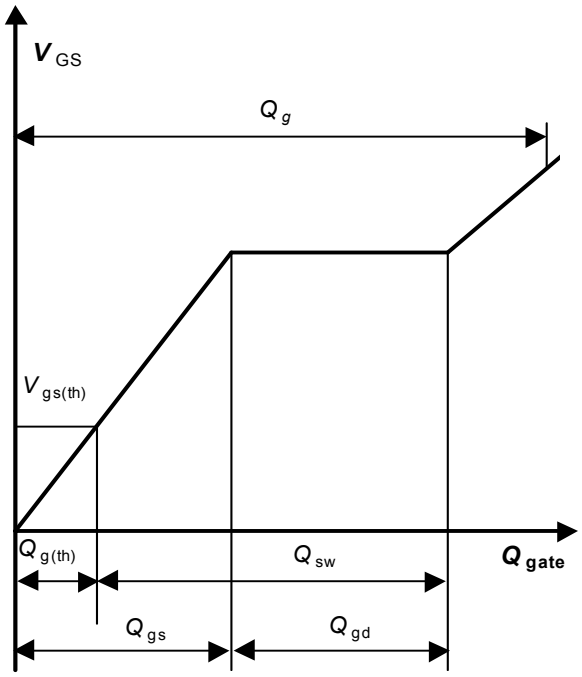


15 Drain-source breakdown voltage

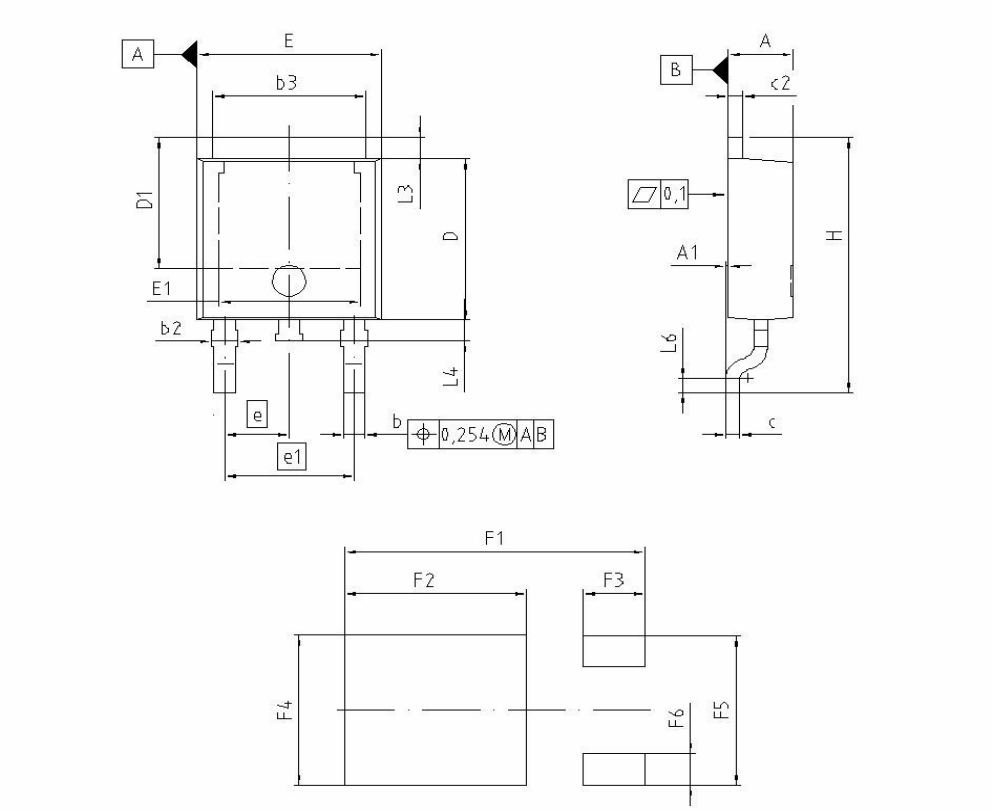
$V_{BR(DSS)}$=f(T_j); I_D=1 mA



16 Gate charge waveforms



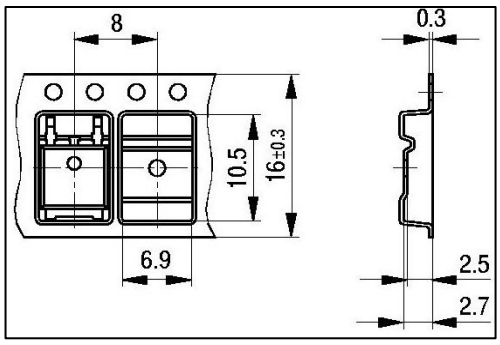
PG-TO252-3: Outline



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	2.184	2.388	0.086	0.094
A1	0.000	0.150	0.000	0.006
b	0.635	0.889	0.025	0.035
b2	0.650	1.150	0.025	0.045
b3	5.004	5.500	0.197	0.217
c	0.460	0.580	0.018	0.023
c2	0.460	0.980	0.018	0.039
D	5.969	6.223	0.235	0.245
D1	5.020	5.320	0.198	0.209
E	6.400	6.731	0.252	0.265
E1	4.900	5.100	0.193	0.201
e	2.286		0.090	
e1	4.572		0.180	
N	3		3	
H	9.400	10.084	0.370	0.397
L3	0.900	1.118	0.035	0.044
L4	0.650	1.016	0.026	0.040
L6	0.510	0.686	0.020	0.027
F1	10.500	10.700	0.413	0.421
F2	6.300	6.500	0.248	0.256
F3	2.100	2.300	0.083	0.091
F4	5.700	5.900	0.224	0.232
F5	5.660	5.860	0.222	0.231
F6	1.100	1.300	0.043	0.051

REFERENCE	JEDEC TO252
SCALE	0 2.0 0 2.0 4mm
EUROPEAN PROJECTION	
ISSUE DATE	20-07-2005
FILE	TO252_1

packaging:



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